## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/506,814	Reexamination LEWIS ET AL.	
Examiner	Art Unit	
BLESSING M FUBARA	1618	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,440,743	08-2002	Kabanov et al.	435/458
	В	US-			
	o	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	н	US-		-	
	-	US-			
	7	US-			
	к	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 98/22517	05-1998	wo	STORCh et al.	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bronich et al., "Effects of Block Length and Structure of Surfactant on Self-Assembly and Solution Behavior of Block Complexes," in Langmuir, 2000, Vol. 16, 481-489).
	v	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.